

<b>Notice of References Cited</b>	Application/Control No. 10/761,822	Applicant(s)/Patent Under Reexamination LEE, YONG	
	Examiner John A. Tweel, Jr.	Art Unit 2636	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,663,708	09-1997	Strawn, Dennis M.	340/465
	B	US-5,677,671	10-1997	Pabla et al.	340/479
	C	US-4,882,570	11-1989	Martinez, Antonio	340/574
	D	US-4,550,304	10-1985	Saitta, Joseph P.	340/472
	E	US-4,994,786	02-1991	Schaffer, Michael	340/478
	F	US-5,086,289	02-1992	Sullivan et al.	340/475
	G	US-5,281,950	01-1994	Le, Hy D.	340/475
	H	US-5,731,755	03-1998	Boxer, Caryn	340/465
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.